

600V N-Channel MOSFET

General Features

- Proprietary New Planar Technology
- > $R_{DS(ON),typ} = 0.45 \ \Omega @V_{GS} = 10V$
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

Applications

- Adaptor
- TV Main Power
- SMPS Power Supply
- LCD Panel Power

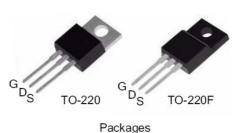
Ordering Information

Part Number	Package	Brand
PTP13N60	TO-220	ï
PTA13N60	TO-220F	ï

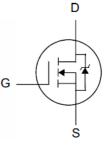
Absolute Maximum Ratings

Dead Free Package and Finish

BV _{DSS}	R _{DS(ON),typ} .	I _D
600V	0.45 Ω	13A



Not to Scale



 $T_C \mbox{=} 25\,^\circ \mbox{C}$ unless otherwise specified

Symbol	Parameter	PTP13N60	PTA13N60	Unit
V _{DSS}	Drain-to-Source Voltage ^[1]	60	600	
V _{GSS}	Gate-to-Source Voltage	±3	30	V
I _D	Continuous Drain Current	1	3	
I _{D @ Tc =100} ℃	Continuous Drain Current @ Tc=100℃	Figu	ire 3	A
I _{DM}	Pulsed Drain Current at V _{GS} =10V ^[2]	Figure 6		
E _{AS}	Single Pulse Avalanche Energy	1000		mJ
dv/dt	Peak Diode Recovery dv/dt ^[3]	5.0		V/ns
D	Power Dissipation	125	50	W
P _D	Derating Factor above 25°C	1.0	0.4	W/°C
T _L T _{PAK}	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300 260		C
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to	o 150	

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	PTP13N60	PTA13N60	Unit
R _{θJC}	Thermal Resistance, Junction-to-Case	1.0	2.5	20.000
R _{θJA}	Thermal Resistance, Junction-to-Ambient	62	100	°CNW



Electrical Characteristics

OFF Characteristics $T_J = 25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	600			V	V_{GS} =0V, I _D =250uA
				1		V _{DS} =600V, V _{GS} =0V
I _{DSS}	Drain-to-Source Leakage Current			100	uA	V _{DS} =480V, V _{GS} =0V, TJ =125℃
	Cate to Source Lookage Current			+100	~ ^	V _{GS} =+30V, V _{DS} =0V
I _{GSS}	Gate-to-Source Leakage Current			-100	nA	V _{GS} =-30V, V _{DS} =0V

C	DN	Chara	cteristics
	~		

ON Characteristics				TJ	⊨=25 ℃ u	nless otherwise specified
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R _{DS(ON)}	Static Drain-to-Source On-Resistance ^[4]		0.45	0.60	Ω	V _{GS} =10V, I _D =6.5A
$V_{GS(TH)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS}=V_{GS}$, $I_D=250uA$
gfs	Forward Transconductance ^[4]		19		S	VDS=30V,ID=13A

Dynamic Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C _{iss}	Input Capacitance		2120	2544	pF	N/ −0)/
C _{rss}	Reverse Transfer Capacitance		23	27		V _{GS} =0V, V _{DS} =25V,
C _{oss}	Output Capacitance		190	228		f=1.0MH _z
Qg	Total Gate Charge		46	56		
Q _{gs}	Gate-to-Source Charge		10		nC	V_{DD} =300V, I _D =13A, V_{GS} =0 to 10V
Q _{gd}	Gate-to-Drain (Miller) Charge		18			

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		16			
trise	Rise Time		26		20	V _{DD} =300V, I _D =13A,
td(OFF)	Turn-Off Delay Time		54		nS	V _{GS} = 10V Rg=9.1 Ω
tfall	Fall Time		38			



Source-Drain Body Diode Characteristics

 $T_J=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I _{SD}	Continuous Source Current ^[4]			13	А	Integral PN-diode in
I _{SM}	Pulsed Source Current ^[4]			52		MOSFET
V _{SD}	Diode Forward Voltage			1.5	V	I _S =13A, V _{GS} =0V
trr	Reverse recovery time			574	ns	V _{GS} =0V ,I _F =13A,
Qrr	Reverse recovery charge			4.5	uC	di⊧/dt=100A/µs

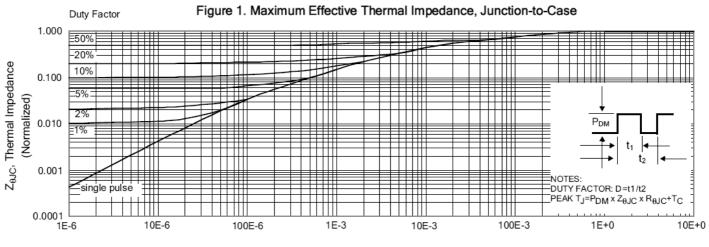
Note:

[1] T_J=+25℃ to +150℃

[2] Repetitive rating; pulse width limited by maximum junction temperature. [3] ISD= 13A di/dt < 100 A/ μ s, VDD < BVDss, TJ=+150 °C.

[4] Pulse width≤380µs; duty cycle≤2%.

Typical Characteristics



t_p, Rectangular Pulse Duration (s)

Maximum Power Dissipation Figure 2. vs Case Temperature

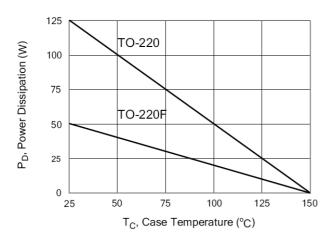


Figure 4. Typical Output Characteristics

20

15

10

5

0

0

I_D, Drain Current (A)

PULSE DURATION = 250 µS

DUTY FACTOR = 0.5%

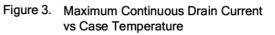
5

10

15

20

MAX, $T_C = 25$ °C



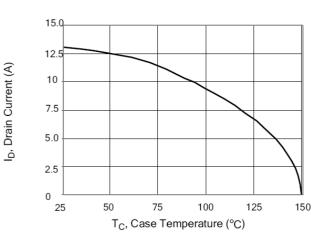
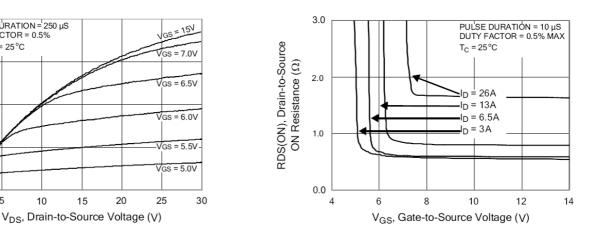
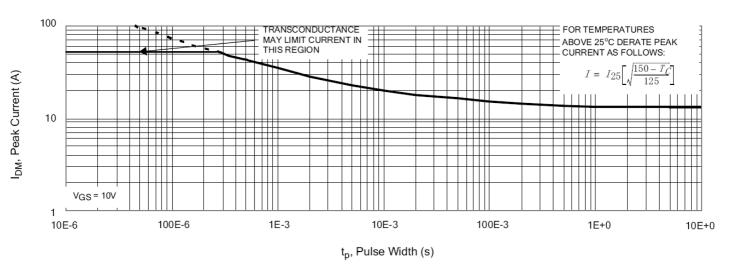


Figure 5. Typical Drain-to-Source ON Resistance vs Gate Voltage and Drain Current



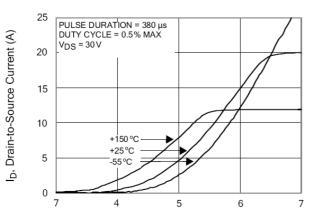
Typical Characteristics(Cont.)



I_{AS}, Avalanche Current (A)

Figure 6. Maximum Peak Current Capability





V_{GS}, Gate-to-Source Voltage (V)

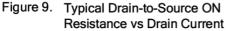


Figure 8. Unclamped Inductive Switching Capability

PTP13N60 PTA13N60

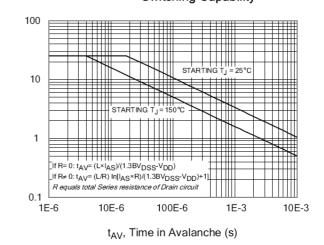
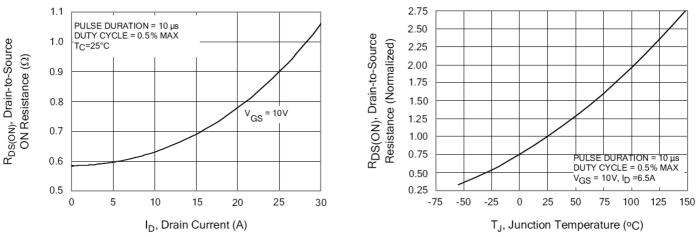
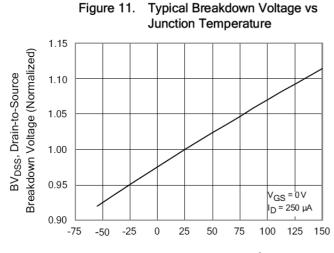


Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature

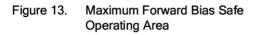


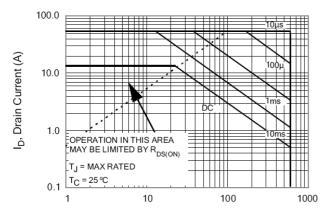


Typical Characteristics(Cont.)



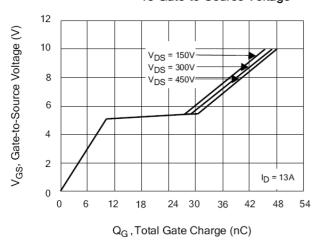
T_J, Junction Temperature (°C)

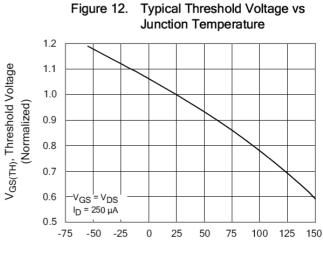




V_{DS}, Drain-to-Source Voltage (V)

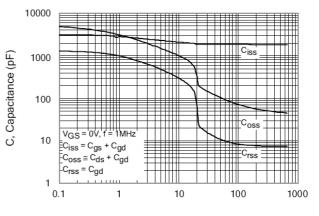
Figure 15. Typical Gate Charge vs Gate-to-Source Voltage





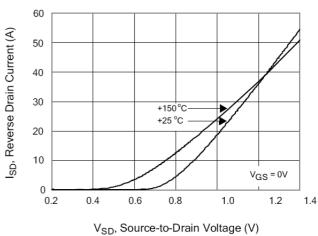
T_J, Junction Temperature (°C)

Figure 14. Typical Capacitance vs Drain-to-Source Voltage



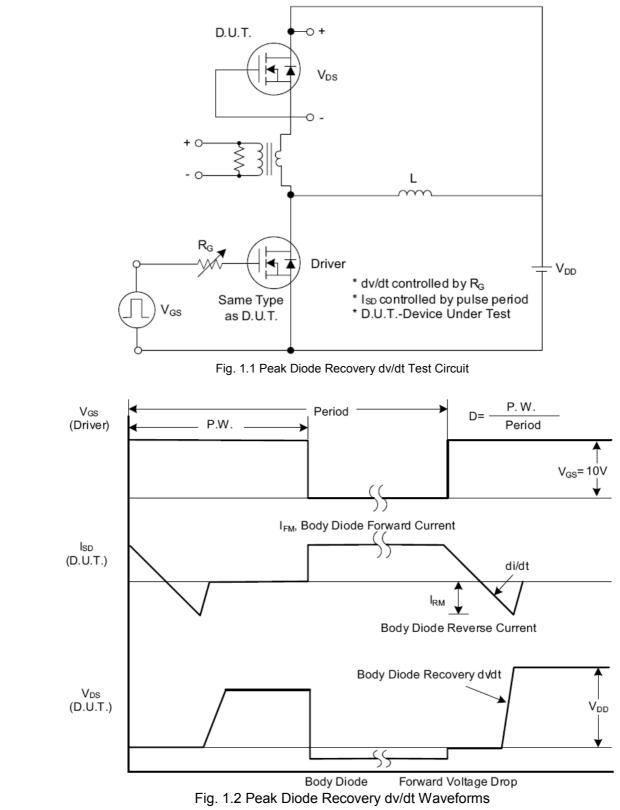
V_{DS}, Drain Voltage (V)

Figure 16. Typical Body Diode Transfer Characteristics





Test Circuits and Waveforms





Test Circuits and Waveforms (Cont.)

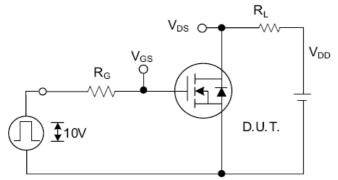


Fig. 2.1 Switching Test Circuit

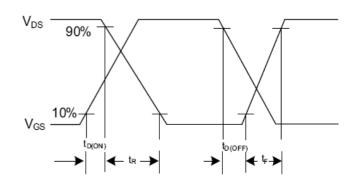


Fig. 2.2 Switching Waveforms

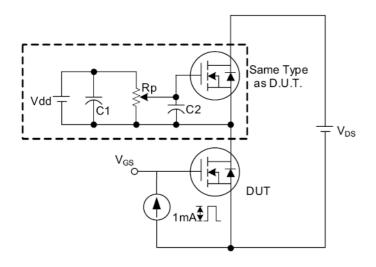


Fig. 3 . 1 Gate Charge Test Circuit

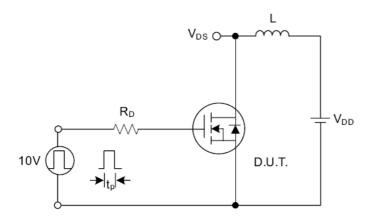


Fig. 4.1 Unclamped Inductive Switching Test Circuit

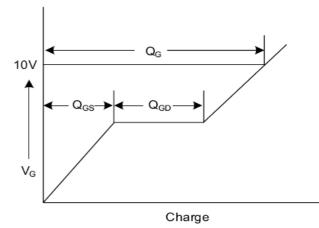
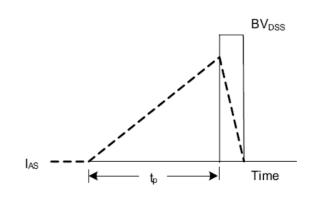
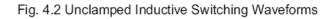


Fig. 3.2 Gate Charge Waveform





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